

Search Notes



Application/Control No.

10/699,664

Examiner

Tu M. Nguyen

Applicant(s)/Patent under Reexamination

MINAMI, TOSHITAKA

Art Unit

3748

SEARCHED

Class	Subclass	Date	Examiner
60	285	6/2007	TMN
	286		
	287		
	288		
	295		
	297		
	300		
	311		
	324		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST search	6/2007	TMN